Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
09/887,492	ORTIZ, LUIS M.
Examiner	Art Unit
MD S. ELAHEE	2614

SEARCHED			
Class	Subclass	Date	Examiner
358	1.15	2/27/2008	ME
400	62		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEAR (INCLUDING SE	CH NOTES EARCH STRATEGY	)
	DATE	EXMR
East	2/27/8	ME
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